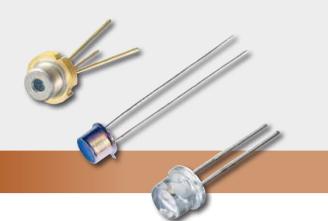
HIGH POWER LASER DIODES FOR RANGE FINDING

PULSED LASER DIODES AND INFRARED LEDS (IREDS) ■

Pulsed Laser Diodes PGA – PGEW Series



Pulsed Laser Diodes - PGA - PGEW Series

Applications

- Range finders
- Safety light curtains
- Adaptive cruise control
- · Laser therapy

Features and Benefits

- Multi cavity lasers concentrate emitting source size
- Quantum well structure
- High peak pulsed power into aperture
- Excellent power stability with temperature

Product Description

Pulsed semiconductor lasers in the near IR are commonly used for long distance time-of-flight or phase-shift range finder systems. Excelitas offers a broad range of suited pulsed 905 nm lasers Lasers designs include multi cavity monolithic structures with up to 4 active areas per chip resulting in up to $100\,\mathrm{W}$ of peak optical output power. Physical stacking of laser chips resulting in up to $300\,\mathrm{W}$ of peak optical output power.

Chip on board assemblies are available for hybrid integration. A selection of 6 metal, hermetically sealed package types are available for harsh environment applications. A molded epoxy resin TO-18 type package is available for high-volume applications.

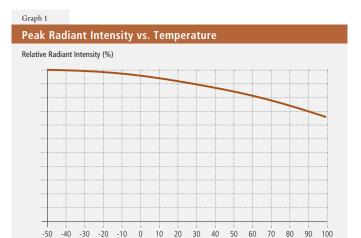
Critical parameters are pulse-width and rise/fall times. The pulse width may be reduced allowing for increased current drive and resulting in higher peak optical power. Quantum well laser design offers rise and fall times of < 1 ns however the drive circuit lay out and package inductance play the greater role and should be designed accordingly. Excelitas offers a variety of package types with different inductive values to assist to this end.

Our core competencies include: MOVPE wafer growth; wafer processing of the grown GaAs wafers; assembly using either epoxy or solder die attach; epoxy encapsulation of lasers mounted on lead frame; hermetically sealer product qualification to MIL STD and custom requirements.

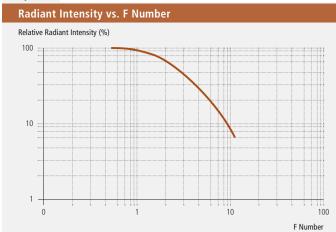
Product Table

Device (X = pkg) (H = RoHS Compliance)	Description		Emitting Area		Typical Peak Power at 10 A, 100 ns	Typical Peak Power at 30 A, 100 ns	Beam Spread Parallel to Junction	Beam Spread Perpendicular to Junction	Typical Temperature	Preferred Packages	
	# of	Total # of Emitting	Width	Height µm	75 µm (3 mils) Stripe Width	225 µm (9 mils) Stripe Width	(FWHM)	(FWHM) Θ±	Coefficient	"S" Metall Can TO-18	"W" Plastic Encapsulated TO-18
	Chips	Stripes	μm								
PGAx1S03H	1	1	75	1	8 W		10	25	0.25	√	✓
PGAx1S09H	1	1	225	1		30 W	10	25	0.25	√	✓
DPGAx1S03H	1	2	75	5	15 W		10	25	0.25	√	✓
DPGAx1S09H	1	2	225	5		50 W	10	25	0.25	✓	✓
TPGAx1S03H	1	3	75	10	23 W		10	25	0.25	√	✓
TPGAx1S09H	1	3	225	10		75 W	10	25	0.25	√	✓
QPGAx1S03H	1	4	75	15	33 W		10	25	0.25	√	✓
QPGAx1S09H	1	4	225	15		100 W	10	25	0.25	√	✓
TPGAx2S03H	2	6	75	175	45 W		10	25	0.25	√	
TPGAx2S09H	2	6	225	175		150 W	10	25	0.25	√	
QPGAx2S03H	2	8	75	225	65 W		10	25	0.25	✓	
QPGAx2S09H	2	8	225	225		200 W	10	25	0.25	✓	
QPGAx3S03H	3	12	75	450	95 W		10	25	0.25	√	
QPGAx3S09H	3	12	225	450		300 W	10	25	0.25	√	

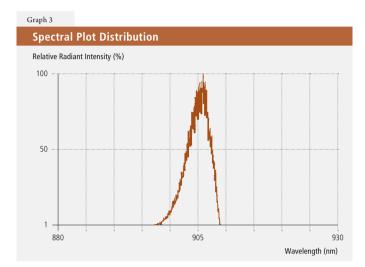
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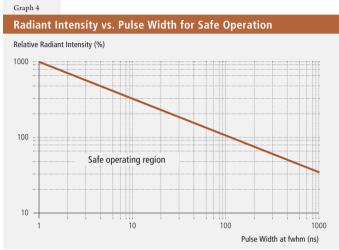


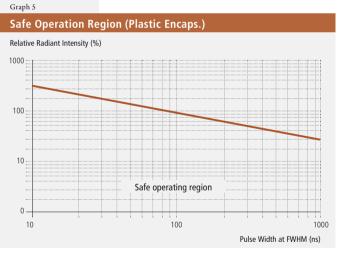
Temperature (Degrees)

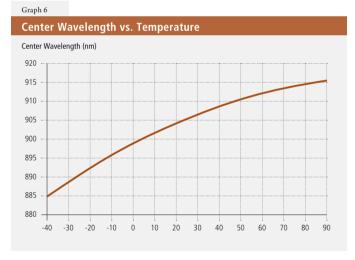


Graph 2

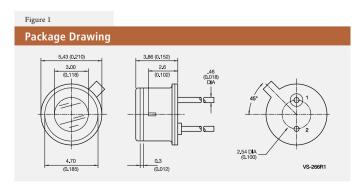


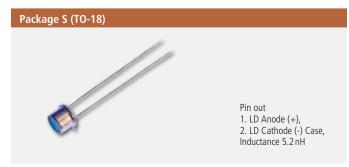






QP6EW currently being verified.

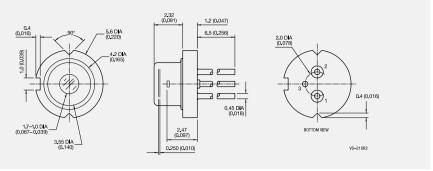




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Figure 2

Package Drawing

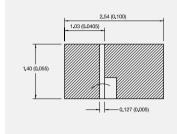


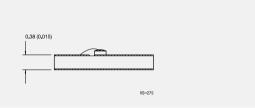
Package U (5 mm CD)



Figure 3

Housing/Package Drawing • Laser Chip on Board





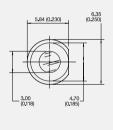
Package Y (Chip on Carrier)

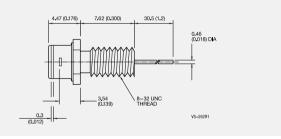


Pin out
1. LD Cathode (-)
chip bottom,
2. LD Anode (+)
chip top,
Inductance 1.6 nH

Figure 4

Package Drawing





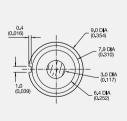
Package C (8-32 Coax)

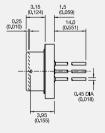


1. LD Anode (+), 2. LD Cathode (-) Case, Inductance 12 nH

Figure 5

Package Drawing







Package R (9 mm CD)

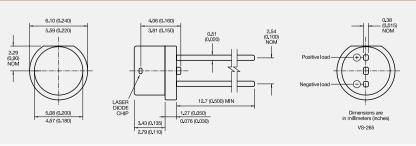


Pin out
1. LD Anode (+),
2. NC,
3. LD Cathode (-) Case,
Inductance 6.8 nH

Figure 6

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Housing/Package Drawing • TO-18-"W" Plastic Package (1S Devices Only)



Package W (TO-18 Plastic)

